

AONS66919

100V N-Channel AlphaSGT™

General Description

- Trench Power AlphaSGTTM technology
- Low R_{DS(ON)}
- Logic Level Driving
- Excellent Q_g x R_{DS(ON)} Product (FOM)
- Pb-Free lead Plating, RoHS and Halogen-Free Compliant

Applications

• High Frequency Switching and Synchronous Rectification

Orderable Part Number

Product Summary

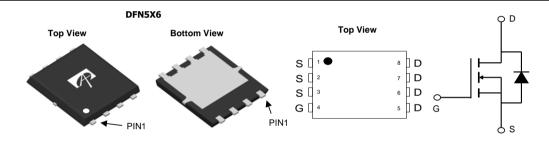
 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 85A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 5.9 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 7.9 m\Omega \end{array}$

100% UIS Tested 100% Rg Tested

Form



Minimum Order Quantity



Package Type

| AONS66919 D | | DFN 5x6 | Tape & Reel | 3000 | |
|--|-------------------------------------|-----------------------------------|-------------|--------|--|
| Absolute Maximun | n Ratings T _A =25°C unle | ess otherwise no | ted | | |
| Parameter | | Symbol | Maximum | Units | |
| Drain-Source Voltage | | V_{DS} | 100 | V | |
| Gate-Source Voltage | | V_{GS} | ±20 | V | |
| Continuous Drain Current ^G | T _C =25°C | | 85 | A | |
| | T _C =100°C | 'D | 62 | | |
| Pulsed Drain Current ^C | | I _{DM} | 169 | \neg | |
| Continuous Drain Current | T _A =25°C | | 23 | A | |
| | T _A =70°C | IDSM | 19 | A | |
| Avalanche Current ^C | | I _{AS} | 48 | А | |
| Avalanche energy | L=0.1mH ^C | E _{AS} | 115 | mJ | |
| | T _C =25°C | P _D | 113 | W | |
| Power Dissipation ^B | T _C =100°C | L D | 45 | VV | |
| | T _A =25°C | Ь | 6.2 | W | |
| Power Dissipation A | T _A =70°C | P _{DSM} | 4.0 | VV | |
| Junction and Storage Temperature Range | | T _J , T _{STG} | -55 to 150 | °C | |

| Thermal Characteristics | | | | | | | | |
|---------------------------------------|------------------------------|-----------------|-----|-----|-------|--|--|--|
| Parameter | | Symbol | Тур | Max | Units | | | |
| Maximum Junction-to-Ambient A | t ≤ 10s | D | 15 | 20 | °C/W | | | |
| Maximum Junction-to-Ambient AD | Steady-State $R_{\theta JA}$ | | 40 | 50 | °C/W | | | |
| Maximum Junction-to-Case Steady-State | | $R_{\theta JC}$ | 0.9 | 1.1 | °C/W | | | |



Electrical Characteristics (T_{.I}=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Тур | Max | Units |
|-----------------------|--|---|-----|------|------|-------|
| STATIC F | PARAMETERS | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 100 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =100V, V _{GS} =0V | | | 1 | μA |
| DSS | | T _J =55° | С | | 5 | |
| I_{GSS} | Gate-Body leakage current | V_{DS} =0V, V_{GS} =±20V | | | ±100 | nA |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}$, $I_{D}=250\mu A$ | 1.5 | 2 | 2.6 | V |
| | Static Drain-Source On-Resistance | V _{GS} =10V, I _D =20A | | 4.8 | 5.9 | mΩ |
| $R_{DS(ON)}$ | | T _J =125° | С | 8.1 | 10.0 | 11177 |
| | | V_{GS} =4.5V, I_{D} =20A | | 6.3 | 7.9 | mΩ |
| g _{FS} | Forward Transconductance | V_{DS} =5V, I_D =20A | | 80 | | S |
| V_{SD} | Diode Forward Voltage | I _S =1A, V _{GS} =0V | | 0.7 | 1 | V |
| Is | Maximum Body-Diode Continuous Current ^G | | | | 85 | Α |
| DYNAMIC | PARAMETERS | | | | | |
| C _{iss} | Input Capacitance | | | 3420 | | pF |
| C _{oss} | Output Capacitance | V_{GS} =0V, V_{DS} =50V, f=1MHz | | 790 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 14 | | pF |
| R_g | Gate resistance | f=1MHz | 0.8 | 1.7 | 2.7 | Ω |
| SWITCHI | NG PARAMETERS | | | | | |
| Q _g (10V) | Total Gate Charge | | | 47 | 66 | nC |
| Q _g (4.5V) | Total Gate Charge | V _{GS} =10V, V _{DS} =50V, I _D =20A | | 22 | 31 | nC |
| Q_{gs} | Gate Source Charge | V _{GS} =10V, V _{DS} =30V, I _D =20A | | 10 | | nC |
| Q_{gd} | Gate Drain Charge | | | 5 | | nC |
| Q _{oss} | Output Charge | V _{GS} =0V, V _{DS} =50V | | 70 | | nC |
| t _{D(on)} | Turn-On DelayTime | | | 11 | | ns |
| t _r | Turn-On Rise Time | V_{GS} =10V, V_{DS} =50V, R_L =2.5 Ω , | | 5.5 | | ns |
| t _{D(off)} | Turn-Off DelayTime | $R_{GEN}=3\Omega$ | | 43 | | ns |
| t _f | Turn-Off Fall Time | | | 9.5 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =20A, di/dt=500A/μs | | 36 | | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =20A, di/dt=500A/μs | | 214 | | nC |

A. The value of R_{BJA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{BJA} t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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Rev.1.2: January 2024 **www.aosmd.com** Page 2 of 6

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $\rm T_{J(MAX)}\!\!=\!\!150^\circ\,$ C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

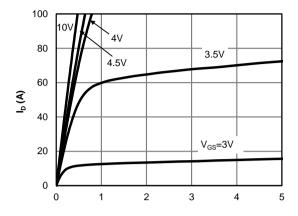
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

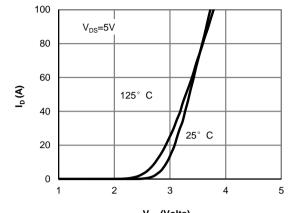
H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}$ C.



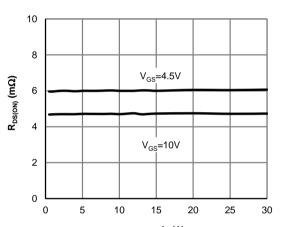
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 $V_{\rm DS}$ (Volts) Figure 1: On-Region Characteristics (Note E)



V_{GS} (Volts) Figure 2: Transfer Characteristics (Note E)



 ${\rm I_D}\left({\rm A} \right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

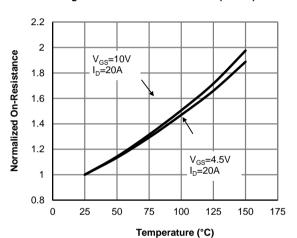


Figure 4: On-Resistance vs. Junction Temperature (Note E)

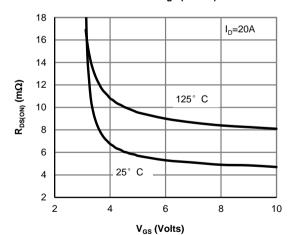
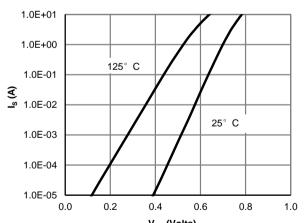


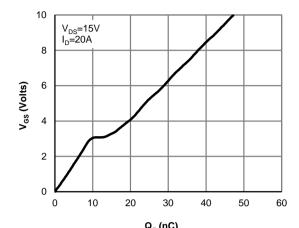
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



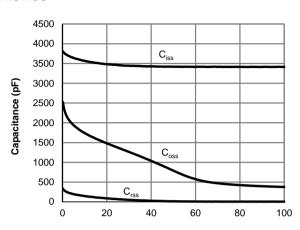
V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



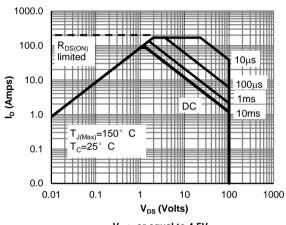
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



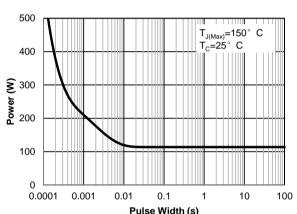
 ${\bf Q_g}$ (nC) Figure 7: Gate-Charge Characteristics



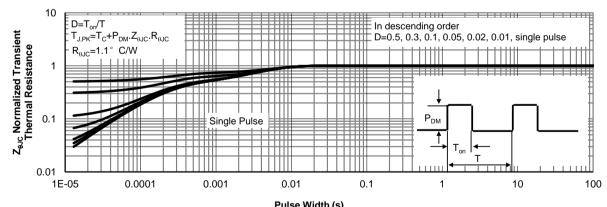
V_{DS} (Volts)
Figure 8: Capacitance Characteristics



V_{GS}> or equal to 4.5V Figure 9: Maximum Forward Biased Safe Operating Area (Note F)



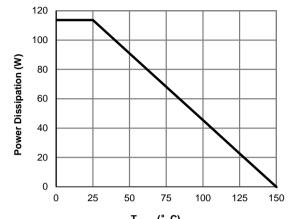
Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toCase (Note F)



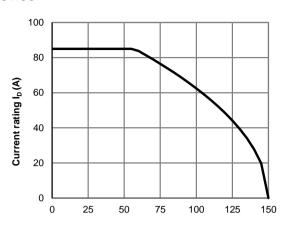
Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



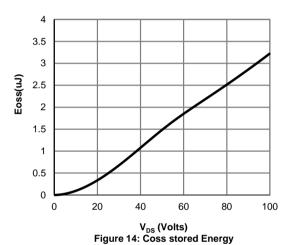
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



T_{CASE} (° C)
Figure 12: Power De-rating (Note F)



T_{CASE} (° C)
Figure 13: Current De-rating (Note F)



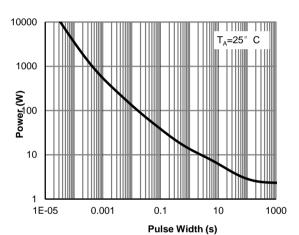
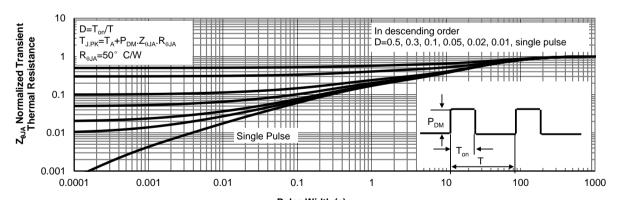


Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

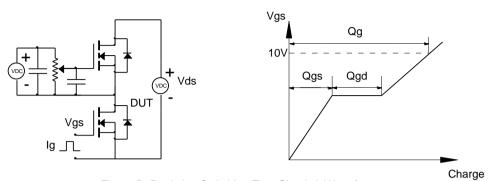


Figure B: Resistive Switching Test Circuit & Waveforms

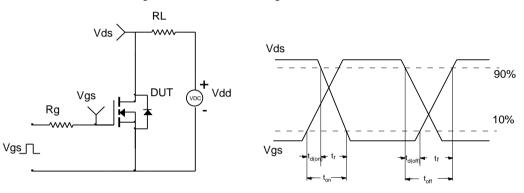


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

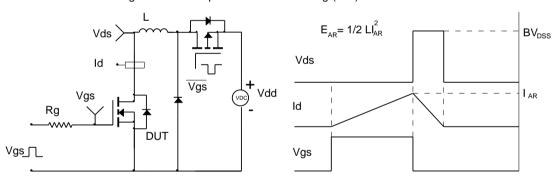
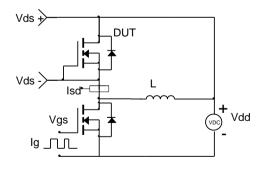
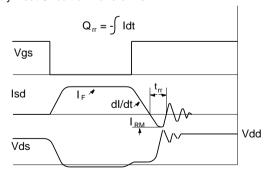


Figure D: Diode Recovery Test Circuit & Waveforms





Rev.1.2: January 2024 **www.aosmd.com** Page 6 of 6